CMOS Digital Integrated Circuits Silicon Monolithic

# 74HC4051D,74HC4052D

### 1. Functional Description

74HC4051D:8-Channel Analog Multiplexer/Demultiplexer 74HC4052D:Dual 4-Channel Analog Multiplexer/Demultiplexer

#### 2. General

The 74HC4051D, 74HC4052D are high speed CMOS ANALOG MULTIPLEXER/DEMULTIPLEXER fabricated with silicon gate C<sup>2</sup>MOS technology. They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

The 74HC4051D has an 8 channel configuration and the 74HC4052D has a 4 channel  $\times$  2 configuration.

The digital signal to the control terminal turns "ON" the corresponding switch of each channel a large amplitude signal ( $V_{CC}$  -  $V_{EE}$ ) can then be switched by the small logical amplitude ( $V_{CC}$  - GND) control signal.

For example, in the case of  $V_{CC}$  = 5 V, GND = 0 V,  $V_{EE}$  = -5 V, signals between -5 V and +5 V can be switched from the logical circuit with a single power supply of 5 V. As the ON-resistance of each switch is low, they can be connected to circuits with low input impedance.

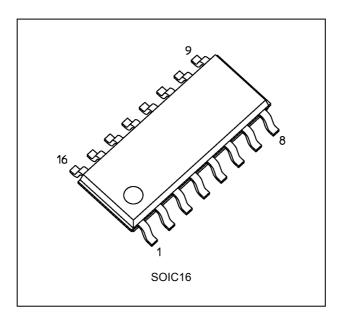
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

### 3. Features

- (1) Wide operating temperature range:  $T_{opr} = -40$  to 125 °C (Note 1)
- (2) Low power dissipation:  $I_{CC}$  = 4.0  $\mu$ A (max) ( $V_{CC}$  = 6.0 V,  $V_{EE}$  = GND,  $T_a$  = 25 °C)
- (3) Low ON-resistance:  $R_{ON} = 50 \Omega$  (typ.) at  $V_{CC} \cdot V_{EE} = 9 V$
- (4) High degree of linearity: THD = 0.02 % (typ.) at  $V_{CC} V_{EE} = 9 V$

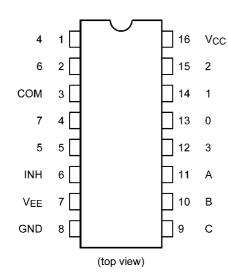
Note 1: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.

### 4. Packaging

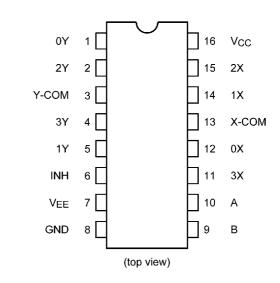


# 5. Pin Assignment



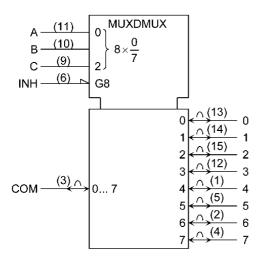


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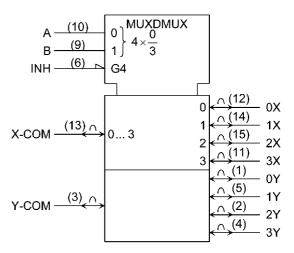


# 6. IEC Logic Symbol

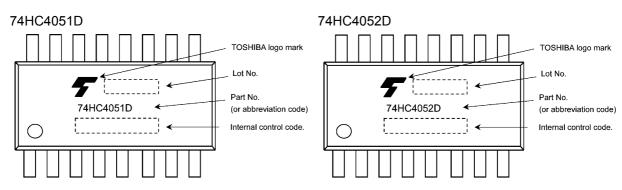
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74HC4052D

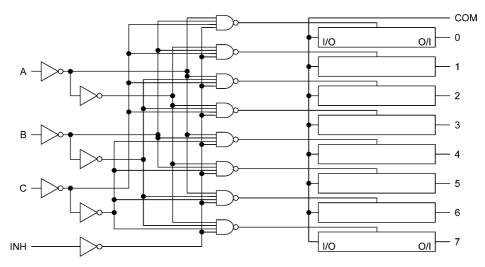


# 7. Marking

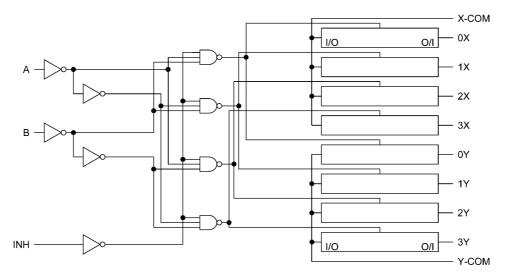


### 8. System Diagram

### 74HC4051D



74HC4052D



### 9. Truth Table

Input Inhibit	Input C*	Input B	Input A	ON Channel 74HC4051D	ON Channel 74HC4052D
L	L	L	L	0	0X, 0Y
L	L	L	Н	1	1X, 1Y
L	L	Н	L	2	2X, 2Y
L	L	Н	Н	3	3X, 3Y
L	Н	L	L	4	_
L	Н	L	Н	5	_
L	Н	Н	L	6	_
L	Н	Н	Н	7	—
Н	Х	Х	Х	None	None

X: Don't care

\*: Except 74HC4052D

## 10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		-0.5 to 7.0	V
Supply voltage	V <sub>EE</sub>		-7.0 to 0	V
Supply voltage	V <sub>CC</sub> -V <sub>EE</sub>		-0.5 to 13.0	V
Input voltage	V <sub>IN</sub>		-0.5 to V <sub>CC</sub> + 0.5	V
Switch I/O voltage	V <sub>I/O</sub>		V <sub>EE</sub> - 0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>		±20	mA
I/O diode current	I <sub>I/OK</sub>		±20	mA
Switch through current	Ι <sub>Τ</sub>		±25	mA
V <sub>CC</sub> /ground current	I <sub>CC</sub>		±50	mA
Power dissipation	PD	(Note 1)	500	mW
Storage temperature	T <sub>stg</sub>		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: P<sub>D</sub> derates linearly with -8 mW/°C above 85 °C.

## 11. Operating Ranges (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		2.0 to 6.0	V
Supply voltage	V <sub>EE</sub>		-6.0 to 0	V
Supply voltage	V <sub>CC</sub> -V <sub>EE</sub>		2.0 to 12.0	V
Input voltage	V <sub>IN</sub>		0 to V <sub>CC</sub>	V
Switch I/O voltage	V <sub>I/O</sub>		V <sub>EE</sub> to V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>	(Note 1)	-40 to 125	°C
Input rise and fall times	t <sub>r</sub> ,t <sub>f</sub>		0 to 50	μS

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V<sub>CC</sub> or GND.

Note 1: Operating Range spec of T<sub>opr</sub> = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.

# **12. Electrical Characteristics**

# 12.1. DC Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit		
High-level input voltage	VIH	_		2.0	1.50	_	_	V		
				4.5	3.15	—	_			
				6.0	4.20	—	_			
Low-level input voltage	VIL	_		2.0		_	0.50	V		
				4.5	—	_	1.35			
				6.0	_	_	1.80			
ON-resistance	R <sub>ON</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	GND	4.5	—	180	240	Ω		
		$V_{I/O}$ = $V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	—	140	190			
			-6.0	6.0	_	135	180			
		$V_{IN} = V_{IH} \text{ or } V_{IL}$	GND	2.0	—	210	—			
		$V_{I/O} = V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	GND	4.5	_	150	200			
			-4.5	4.5	_	130	170			
			-6.0	6.0	_	125	170			
			GND	2.0	_	220	—			
					GND	4.5	_	95	130	
			-4.5	4.5		75	100			
			-6.0	6.0	_	70	100			
Difference of ON-resistance	$\Delta R_{ON}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5		10	30	Ω		
between switches		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	5	12			
		II/O ≤ 2 IIIA	-6.0	6.0	_	5	10			
Input/Output leakage current	I <sub>OFF</sub>	$V_{OS} = V_{CC}$ or GND	GND	6.0	—	—	±0.06	μA		
(Switch OFF)		$V_{IS} = GND \text{ or } V_{CC}$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	-6.0	6.0	—	—	±0.1			
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	6.0	_	_	±0.06	μA		
(Switch ON)		$V_{IN} = V_{IH} \text{ or } V_{IL}$	-6.0	6.0	_	—	±0.1			
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	—	—	±0.1	μA		
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	—	—	4.0	μA		
			-6.0	6.0	_	_	8.0			

# 12.2. DC Characteristics (Unless otherwise specified, $T_a = -40$ to 85 °C)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		2.0	1.50	_	V
				4.5	3.15	_	]
				6.0	4.20	_	]
Low-level input voltage	VIL	_		2.0	_	0.50	V
				4.5		1.35	
				6.0	_	1.80	
ON-resistance	R <sub>ON</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5		300	Ω
		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5		240	
		II/0 ≤ 2 IIIA	-6.0	6.0		225	
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{I/O} = V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	GND	4.5		250	
			-4.5	4.5		215	
			-6.0	6.0		215	
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{I/O} = V_{CC}$ $I_{I/O} \le 2 \text{ mA}$	GND	4.5		165	
			-4.5	4.5		125	
			-6.0	6.0		125	
Difference of ON-resistance	$\Delta R_{ON}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5		35	Ω
between switches		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5		15	
			-6.0	6.0		12	
Input/Output leakage current	I <sub>OFF</sub>	$V_{OS} = V_{CC}$ or GND	GND	6.0	_	±0.6	μA
(Switch OFF)		$V_{IS} = GND \text{ or } V_{CC}$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	-6.0	6.0	_	±1.0	
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	6.0	_	±0.6	μΑ
(Switch ON)		$V_{IN} = V_{IH} \text{ or } V_{IL}$	-6.0	6.0		±1.0	μA
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	_	±1.0	μA
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0		40.0	μA
			-6.0	6.0	_	80.0	

# 12.3. DC Characteristics (Note) (Unless otherwise specified, T<sub>a</sub> = -40 to 125 °C)

Characteristics	Symbol	Test Condition	$V_{EE}$ (V)	V <sub>CC</sub> (V)	Min	Мах	Unit
High-level input voltage	V <sub>IH</sub>	—		2.0	1.50	_	V
				4.5	3.15	_	
				6.0	4.20	_	1
Low-level input voltage	V <sub>IL</sub>	_		2.0	_	0.50	V
				4.5	_	1.35	
				6.0		1.80	
ON-resistance	R <sub>ON</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	340	Ω
		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5		275	
		$1/0 \ge 2$ IIIA	-6.0	6.0		255	
		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5		285	
		$V_{I/O} = V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5		245	
			-6.0	6.0		245	
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{I/O} = V_{CC}$ $I_{I/O} \le 2 \text{ mA}$	GND	4.5		190	
			-4.5	4.5		145	
			-6.0	6.0		145	
Difference of ON-resistance	$\Delta R_{ON}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	35	Ω
between switches		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	15	
			-6.0	6.0		12	
Input/Output leakage current	I <sub>OFF</sub>	$V_{OS} = V_{CC}$ or GND	GND	6.0	_	±3.0	μA
(Switch OFF)		$V_{IS} = GND \text{ or } V_{CC}$ $V_{IN} = V_{IL}$	-6.0	6.0	_	±5.0	
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	6.0		±3.0	μA
(Switch ON)		$V_{IN} = V_{IH} \text{ or } V_{IL}$	-6.0	6.0		±5.0	
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0		±1.0	μA
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0		80.0	μA
			-6.0	6.0	—	160.0	

Note: Operating Range spec of T<sub>opr</sub> = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.

#### 12.4. AC Characteristics (Unless otherwise specified, C<sub>L</sub> = 50 pF, T<sub>a</sub> = 25 °C, Input: t<sub>r</sub> = t<sub>f</sub> = 6 ns)

Characteristics	Part Number	Symbol	Test Condition	$V_{EE}\left(V\right)$	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
Phase difference		Φι/Ο	—	GND	2.0	_	18	25	ns
between input to output				GND	4.5	_	7	12	
				GND	6.0	_	6	10	
				-4.5	4.5		5	8	
Output enable time	74HC4051D	t <sub>PZL</sub> ,t <sub>PZH</sub>	R <sub>L</sub> = 1 kΩ	GND	2.0		90	145	ns
			Figure 1	GND	4.5		30	45	
				GND	6.0		25	35	
				-4.5	4.5	-	24	34	
	74HC4052D		R <sub>L</sub> = 1 kΩ Figure 1	GND	2.0	_	90	145	
				GND	4.5	_	30	45	
				GND	6.0	_	25	35	
				-4.5	4.5	_	24	34	
Output disable time	74HC4051D	t <sub>PLZ</sub> ,t <sub>PHZ</sub>	$R_L = 1 k\Omega$	GND	2.0	_	56	85	ns
		-	Figure 1	GND	4.5	_	26	35	
				GND	6.0	_	25	33	
				-4.5	4.5	_	24	32	
	74HC4052D		$R_L = 1 k\Omega$ Figure 1	GND	2.0	_	56	85	-
				GND	4.5	_	26	35	
				GND	6.0	_	25	33	
				-4.5	4.5	_	24	32	
Control input capacitance		C <sub>IN</sub>	—	_	_	_	5	10	pF
Common terminal	74HC4051D	C <sub>IS</sub>	Figure 2	-5.0	5.0	_	36	70	pF
capacitance	74HC4052D					_	19	40	
Switch terminal	74HC4051D	C <sub>OS</sub>	Figure 2	-5.0	5.0	_	7	15	pF
capacitance	74HC4052D					_	7	15	
Feedthrough	74HC4051D	C <sub>IOS</sub>	Figure 2	-5.0	5.0	_	0.95	2	pF
capacitance	74HC4052D					_	0.85	2	
Power dissipation	74HC4051D	C <sub>PD</sub>	Figure 2	-5.0	5.0	_	11	_	pF
capacitance	74HC4052D		(Note 1)			_	19	—	

Note 1: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

 $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}$ 



# 12.5. AC Characteristics (Unless otherwise specified, $C_L$ = 50 pF, $T_a$ = -40 to 85 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Part Number	Symbol	Test Condition	$V_{EE}\left(V\right)$	V <sub>CC</sub> (V)	Min	Max	Unit
Phase difference between		Φι/Ο	—	GND	2.0	_	30	ns
input to output				GND	4.5	_	15	
				GND	6.0	_	13	
				-4.5	4.5	_	10	
Output enable time	74HC4051D	t <sub>PZL</sub> ,t <sub>PZH</sub>	$,t_{PZH}$ $R_L = 1 k\Omega$	GND	2.0	_	150	ns
			Figure 1	GND	4.5	_	55	
				GND	6.0	—	42	
				-4.5	4.5	_	41	
	74HC4052D		R <sub>L</sub> = 1 kΩ	GND	2.0	_	150	
			Figure 1	GND	4.5	—	55	
				GND	6.0	_	42	
				-4.5	4.5	_	41	
Output disable time	74HC4051D	t <sub>PLZ</sub> ,t <sub>PHZ</sub>	R <sub>L</sub> = 1 kΩ	GND	2.0	_	90	ns
		-	Figure 1 R <sub>L</sub> = 1 kΩ Figure 1	GND	4.5	_	45	
				GND	6.0	_	40	
				-4.5	4.5	—	39	
	74HC4052D			GND	2.0	_	90	-
				GND	4.5	_	45	
				GND	6.0	—	40	
				-4.5	4.5	_	39	
Control input capacitance		C <sub>IN</sub>	—	_	_	_	10	pF
Common terminal	74HC4051D	CIS	Figure 2	-5.0	5.0	—	70	pF
capacitance	74HC4052D					_	40	
Switch terminal capacitance	74HC4051D	C <sub>OS</sub>	Figure 2	-5.0	5.0	_	15	pF
	74HC4052D					_	15	
Feedthrough capacitance	74HC4051D	C <sub>IOS</sub>	Figure 2	-5.0	5.0		2	pF
	74HC4052D					_	2	

#### 12.6. AC Characteristics (Note) (Unless otherwise specified, $C_L = 50$ pF, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 6$ ns)

·	-		-			-		-
Characteristics	Part Number	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
Phase difference between		Φι/Ο	—	GND	2.0	_	35	ns
input to output				GND	4.5	_	17	
				GND	6.0	_	15	
				-4.5	4.5	_	12	
Output enable time	74HC4051D	t <sub>PZL</sub> ,t <sub>PZH</sub>		GND	2.0	_	155	ns
			Figure 1	GND	4.5	_	62	]
				GND	6.0		47	
				-4.5	4.5	_	46	
	74HC4052D		$R_L = 1 k\Omega$	GND	2.0		155	
			Figure 1	GND	4.5	—	62	
				GND	6.0	_	47	
				-4.5	4.5	_	46	
Output disable time	74HC4051D		$\begin{array}{c} PLZ, t_{PHZ} \\ Figure 1 \\ \\ R_{L} = 1 \ k\Omega \\ \\ R_{L} = 1 \ k\Omega \\ \\ Figure 1 \end{array}$	GND	2.0	—	95	ns
				GND	4.5	_	52	
				GND	6.0	_	45	-
				-4.5	4.5	—	44	
	74HC4052D			GND	2.0	_	95	
				GND	4.5	_	52	
				GND	6.0	—	45	
				-4.5	4.5		44	
Control input capacitance		C <sub>IN</sub>	—	—	—	_	10	pF
Common terminal	74HC4051D	C <sub>IS</sub>	Figure 2	-5.0	5.0		70	pF
capacitance	74HC4052D			-5.0	5.0		40	
Switch terminal capacitance	74HC4051D	C <sub>OS</sub>	Figure 2	-5.0	5.0	_	15	pF
	74HC4052D	C <sub>OS</sub>		-5.0	5.0		15	
Feedthrough capacitance	74HC4051D	C <sub>IOS</sub>	Figure 2	-5.0	5.0		2	pF
	74HC4052D			-5.0	5.0	_	2	

Note: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.

# 12.7. Analog Switch Characteristics ( $T_a = 25 \ ^{\circ}C$ ) (Note)

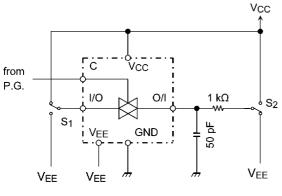
Characteristics	Part Number	Symbol	Test Condition		V <sub>EE</sub> (V)	$V_{CC}\left(V ight)$	Тур.	Unit
Sine Wave Distortion		THD	R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 50 pF	V <sub>IN</sub> = 4.0 V <sub>p-p</sub>	-2.25	2.25	0.025	%
			f <sub>IN</sub> = 1 kHz	V <sub>IN</sub> = 8.0 V <sub>p-p</sub>	-4.5	4.5	0.020	
				V <sub>IN</sub> = 11.0 V <sub>p-p</sub>	-6.0	6.0	0.018	
Maximum frequency		f <sub>MAX(I/O)</sub>	Adjust f <sub>IN</sub> voltage to obtain	(Note 1)	-2.25	2.25	120	MHz
response	74HC4051D		0 dBm at V <sub>OS</sub> Increase f <sub>IN</sub> frequency until	(Note 2)			45	
	74HC4052D		dB meter reads -3 dB				70	
		1	$R_L = 50 \Omega, C_L = 10 pF$	(Note 1)	-4.5	4.5	190	
	74HC4051D			(Note 2)			70	
	74HC4052D						110	
		1		(Note 1)	-6.0	6.0	200	
	74HC4051D			(Note 2)			85	
	74HC4052D						140	
Feed through		FTH	$V_{IN}$ is centered at ( $V_{CC}/2$ ).		-2.25	2.25	-50	dB
attenuation (switch OFF)			Adjust input for 0 dBm. $R_L = 600 \Omega$ , $C_L = 50 pF$ ,		-4.5	4.5	-50	
			f <sub>IN</sub> = 1 MHz, sine wave Figure 4		-6.0	6.0	-50	
Crosstalk (control input		X <sub>talk</sub>	$R_L$ = 600 Ω, $C_L$ = 50 pF,		-2.25	2.25	60	mV
to signal output)			$f_{IN} = 1 \text{ MHz},$ square wave (t <sub>r</sub> = t <sub>f</sub> = 6 ns)		-4.5	4.5	140	
			Figure 5		-6.0	6.0	200	
Crosstalk (between any switches)		X <sub>talk</sub>	Adjust V <sub>IN</sub> to obtain 0 dBm at input.		-2.25	2.25	-50	dB
ownonco			$R_L = 600 \Omega$ , $C_L = 50 pF$ ,		-4.5	4.5	-50	
			f <sub>IN</sub> = 1 MHz, sine wave Figure 6		-6.0	6.0	-50	

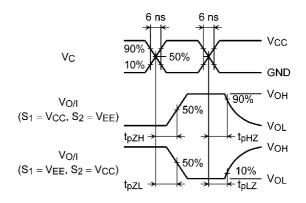
Note: These characteristics are determined by design of devices.

Note 1: Input COMMON terminal, and measured at SWITCH terminal.

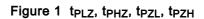
Note 2: Input SWITCH terminal, and measured at COMMON terminal.

# 13. AC Test Circuit





P.G.: Pulse generator



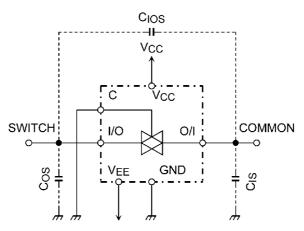


Figure 2 CIOS, CIS, COS

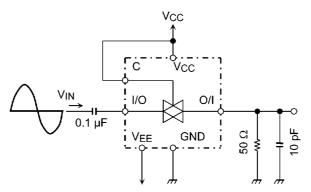


Figure 3 Frequency Response

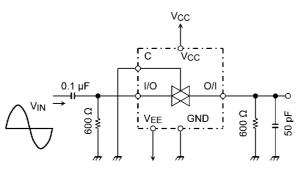
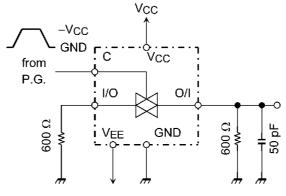
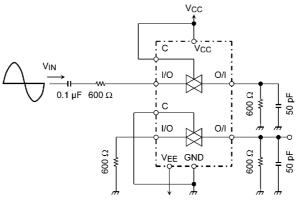


Figure 4 Feedthrough Attenuation



P.G.: Pulse generator





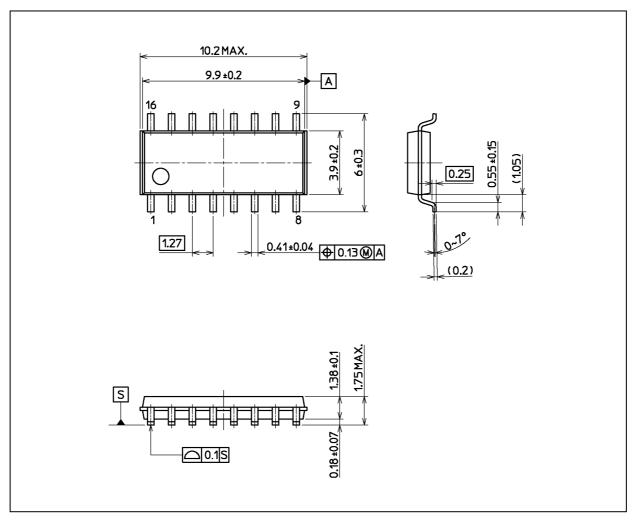




# 74HC4051D,74HC4052D

### **Package Dimensions**

Unit: mm



Weight: 0.15 g (typ.)

Package Name(s)

Nickname: SOIC16

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